



**MAHATMA GANDHI UNIVERSITY
KOTTAYAM**

4927/EB VII-ASSISTANT/2018/EB 7

Dated: 28/02/2019

S3, S5, S7&S8 B.Tech. Degree(Supple/Mercy chance) Examinations, January 2019

**Schedule for Practical Examinations
Electronics and Instrumentation Engineering (Zone III)**

1. Centre of Examination: KMEA Engineering College, Edathala

SEM	NS/OS	SUBJECT	CODE	DATE
5	NS	INSTRUMENTATION LAB-I	EI010507	06/03/2019
5	NS	INTEGRATED CIRCUITS LAB	EI010598	05/03/2019
8	NS	PROCESS CONTROL LAB	EI010806	07/03/2019
8	NS	COURSE VIVA	EI010808	05/03/2019

2. Centre of Examination : Federal Institute of Science and Technology, Mookkannoor

SEM	NS/OS	SUBJECT	CODE	DATE
3	NS	ELECTRONIC CIRCUITS LAB-I	EI010307	05/03/2019
5	NS	INSTRUMENTATION LAB-I	EI010507	06/03/2019
5	NS	INTEGRATED CIRCUITS LAB	EI010598	05/03/2019
7	NS	INSTRUMENTATION LAB-II	EI010707	07/03/2019
7	NS	SYSTEM SIMULATION LAB	EI010708	08/03/2019
8	NS	PROCESS CONTROL LAB	EI010806	09/03/2019

3. Centre of Examination :SNM Institute of Management and Technology,Maliankara

SEMESTER	DATES	Name of the Paper/ Subject for which Practical is to be conducted
VIII New Scheme)	08/03/2019	IC010 806 System Simulation Laboratory
VII (New Scheme)	05/03/2019	IC010 707 Process Control lab
V(New Scheme)	06/03/2019	IC010 508 Linear Integrated Circuits Lab
V(New Scheme)	07/03/2019	IC010 507Microprocessor and Microcontroller Lab
III(New Scheme)	08/03/2019	IC010 307 Basic Electronics Lab

4. Centre of Examination :Rajagiri School of Engineering &Technology, Kakkanad

Sem	Date	Lab Name/ Code
S3	06/03/2019	AI 010 307 ANALOG CIRCUITS LAB
S5	08/03/2019	AI010 507 INDUSTRIAL ELECTRONICS LAB
S7	06/03/2019	AI010707 DSP LAB
S7	05/03/2019	AI010708 INDUSTRIAL INSTRUMENTATION LAB
S8	09/03/2019	AI010806 PROCESS CONTROL LAB
S5 (OS)	08/03/2019	DIGITAL IC LAB

**5. Centre of Examination :Adi Shankara Institute of Engineering and Technology,
Kalady**

SEMESTER	DATE	NAME OF THE LAB
S7	05/03/2019	DSP LAB
S5	07/03/2019	INDUSTRIAL ELECTRONICS LAB
S3	06/03/2019	AC1 LAB

Sd/-

ASSISTANT REGISTRAR XI(EXAMS)
FOR CONTROLLER OF EXAMINATIONS